## Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination HANKIN ET AL. | Examiner | Art Unit | Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,078,908	06-2000	Schmitz, Kim	705/50
*	В	US-2004/0203354	10-2004	Yue, Lin	455/041.1
*	С	US-2003/0103088	06-2003	Dresti et al.	345/835
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					·
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	Р					
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	R					
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	Т					

## **NON-PATENT DOCUMENTS**

	NON I ATENT DOCUMENTO						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	v						
	w						
	x						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.